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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 10449-032001	Application No. 09/748,506
MAR 3 1 2003 Information Disclosure Statement by Applicant		^{Applicant} Koji Hayashi et al.	
(Use several si	neets if necessary)	Filing Date December 26, 2000	Group Art Unit 2653

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 10449-032001

Application No. 09/748,506

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Applicant Koji Hayashi et al.

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(37 CFR §1.98(b))

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Attorney's Docket No. 10449-032001

Application No. 09/748,506

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Koji Hayashi et al.

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(37 CFR §1.98(b))

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Application No. 09/748,506

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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 10449-032001

Application No. 09/748,506

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